

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2302	438/14.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/11/30 09:07
L2	873	438/648.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/11/30 09:13
L3	998	438/656.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/11/30 09:19
L4	0	(microelectronic (micro near electronic)) AND (device chip die) AND first AND inspect\$3 AND intermediate AND clean\$3 AND second AND fearture AND wafer AND product\$3 AND conduct\$3 AND buffer AND AlCu AND TiN AND Ti AND calibrat\$3.CLM.	US-PGPUB; USPAT	OR	ON	2006/11/30 09:23